Notice of References Cited Application/Control No. 10/539,891 Examiner Li Zheng Applicant(s)/Patent Under Reexamination NAPIER ET AL. Page 1 of 1 U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,677,145	01-2004	Mukerji et al.	435/193
*	В	US-6,825,017	11-2004	Browse et al.	435/190
	С	US- ·			
	D	US-			
	Ε	US-			
	Ε	US-		:	
	G	US-			
	Н	US-			
	١	US-			
	J	US-		·	
	К	US-			
	L	US-			1781
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0				·	
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Sayanova et al. 2006, FEBS Letters 580:1946-1952
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.